
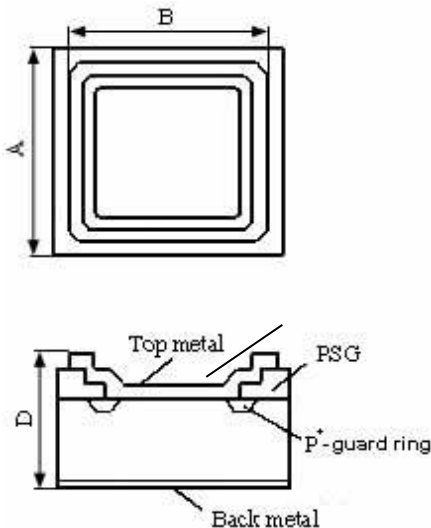


		5A/40V. Die Size-65mil.			
Electrical Characteristics	Symbol	Unit	Spec. limit	Die Sort	
Breakdown Voltage @ $I_R=10\text{mA}$	V_{BR}	V	40	45	
Average Rectified Forward Current	$I_{F(AV)}$	A	5,0	-	
DC Forward Voltage @ 25°C, $I_F=5,0\text{A}$	V_F	V	0,57	0,55	
Maximum Reverse Current @ 25°C, $V_R=45\text{V}$ @ 25°C, $V_R=40\text{V}$ @ 125°C, $V_R=40\text{V}$	I_R	mA	- 0,060 30,0	0,060 0,040 25,0	
Peak Forward Surge Current 8,3ms single half sine-wave superimposed on rated load (JEDEC METHOD)	I_{FSM}	A	110	-	
Peak Repetitive Reverse Surge Current @ 2,0µs, f=1kHz., $T_J<150^\circ\text{C}$.	I_{RRM}	A	2,5		
Electrostatic Discharge Voltage. JEDEC Method. ESD HBM. Contact.	ESD	kV	±8 (contact)		
Voltage Rate of Change	dV/dt	V/µS	10.000		
Operating Junction Temperature	T_J	°C	150		



DIM	ITEM	µm
A _x A _y	Wafer Form Die Size	1650
B _x B _y	Top Metal Size	1510
D	Thickness	300max.
Scribe line Width		80

Top metal:
 a) **Al** – for Wire Bonding;
 b) **Al-Ni-Ag** – for Soldering.
 Backside metal: **Ti-Ni-Ag**.